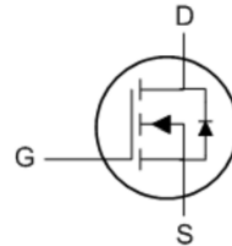
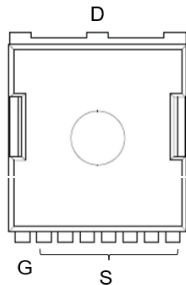


Description
150V N-CHANNEL ENHANCEMENT MODE POWER MOSFET
Features

- Device Rating $V_{DS} = 150V$, $I_D = 205A$
- $R_{DS(ON)} = 2.8m\Omega$ (typ.) @ $V_{GS} = 10V$, $I_D = 50A$
- Advanced Split Gate Device Design
- RoHS Compliant & Halogen-Free
- Qualified according to JEDEC for target applications
- 100% avalanche test

Application

- High Performance Synchronous Rectification
- Brushless DC Motor Control
- Load Switch and eFuse
- Battery Protection

Package


TOLL
JFG205N150Q

Absolute Maximum Ratings $T_J=25^\circ C$ unless otherwise specified

Symbol	Parameter	Value	Units	
V_{DS}	Drain-Source Voltage	150	V	
V_{GS}	Gate-Source Voltage	± 20	V	
I_D	Continuous Drain Current, $V_{GS} @ 10V$ ^{note1}	$T_C = 25^\circ C$	205	A
		$T_C = 100^\circ C$	130	A
I_{DM}	Pulsed Drain Current ^{note2}	820	A	
P_D	Power Dissipation ^{note4}	$T_C = 25^\circ C$	312	W
	Power Dissipation	$T_A = 25^\circ C$	3.12	W
E_{AS}	Single Pulsed Avalanche Energy ^{note3}	1693	mJ	
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ C$	

Thermal characteristics

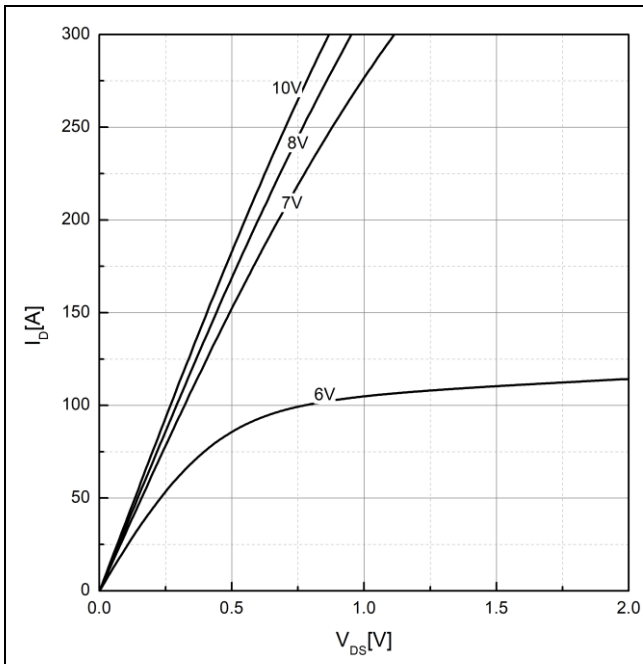
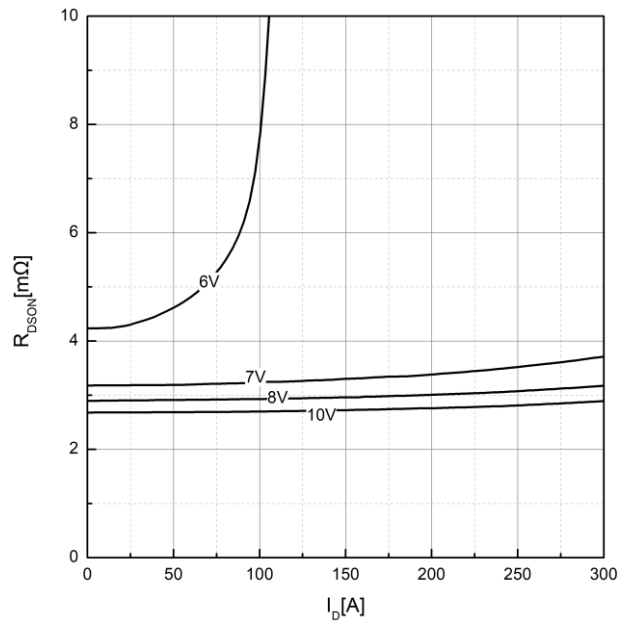
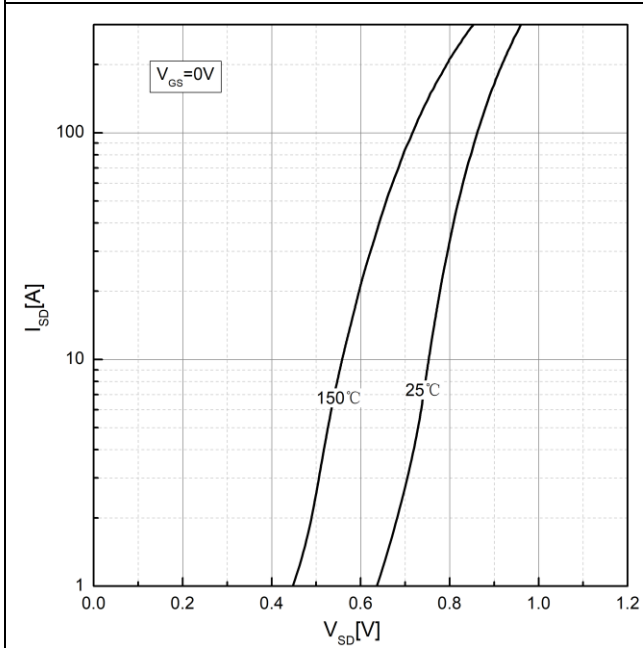
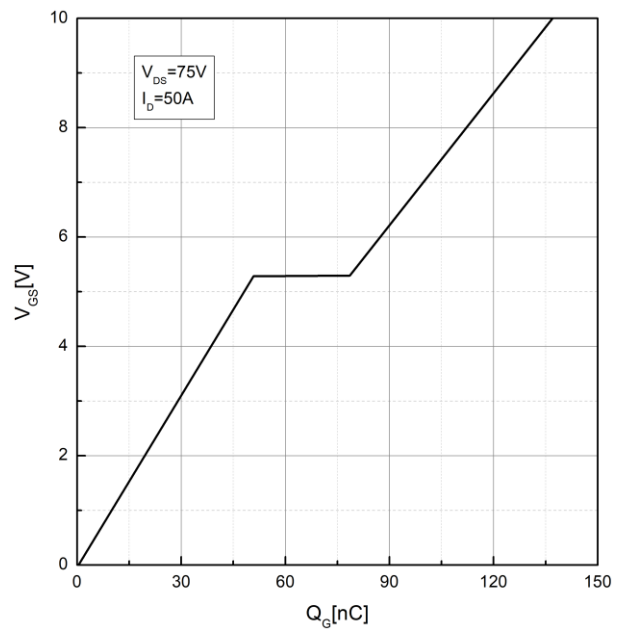
Symbol	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case ^{note1}	-	0.4	-	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient (mounted on 1 inch square PCB)	-	-	40	$^\circ C/W$

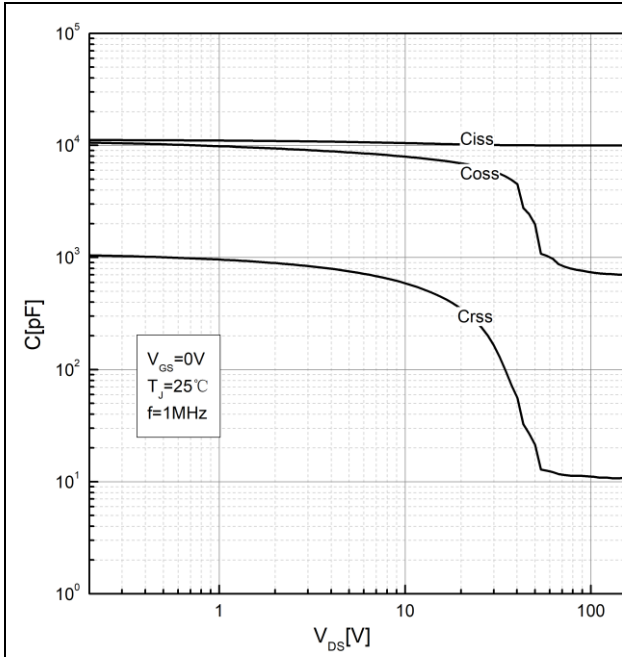
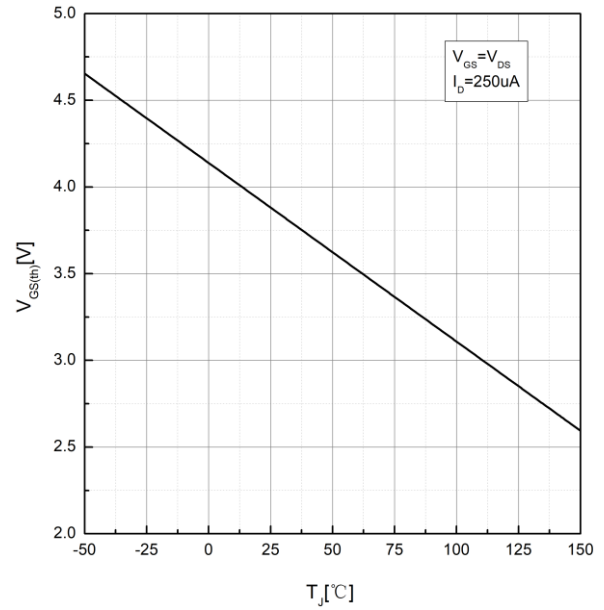
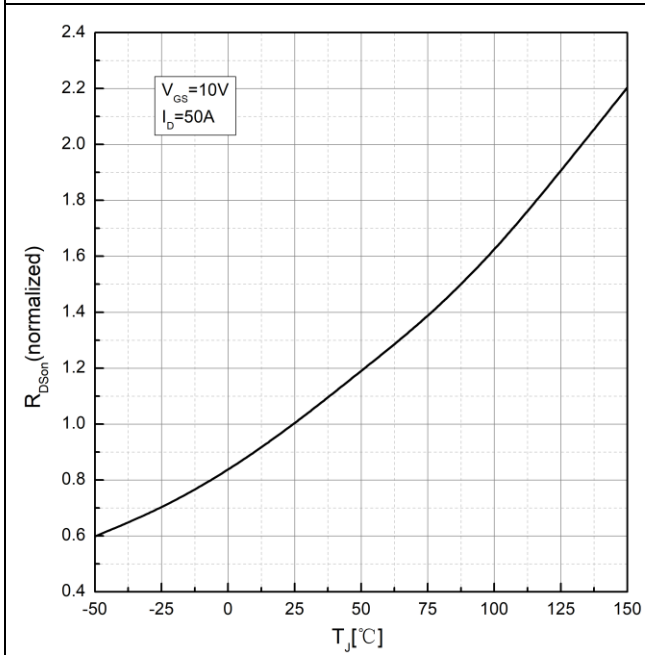
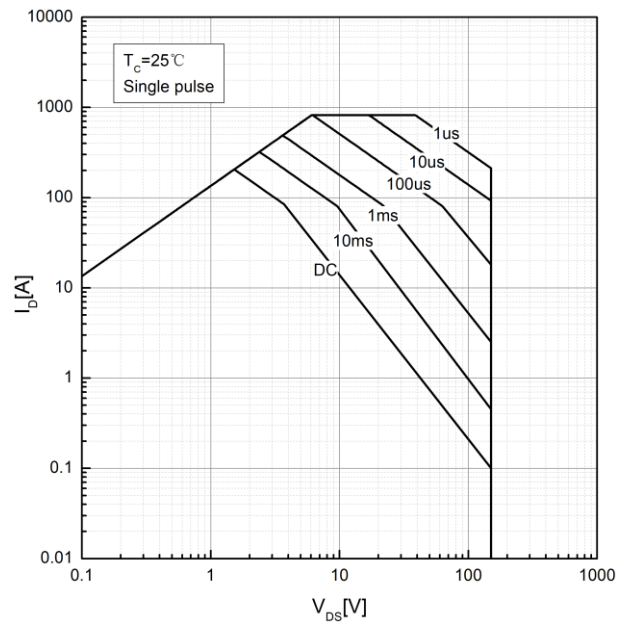
Electrical Characteristics $T_J=25^{\circ}\text{C}$ unless otherwise specified

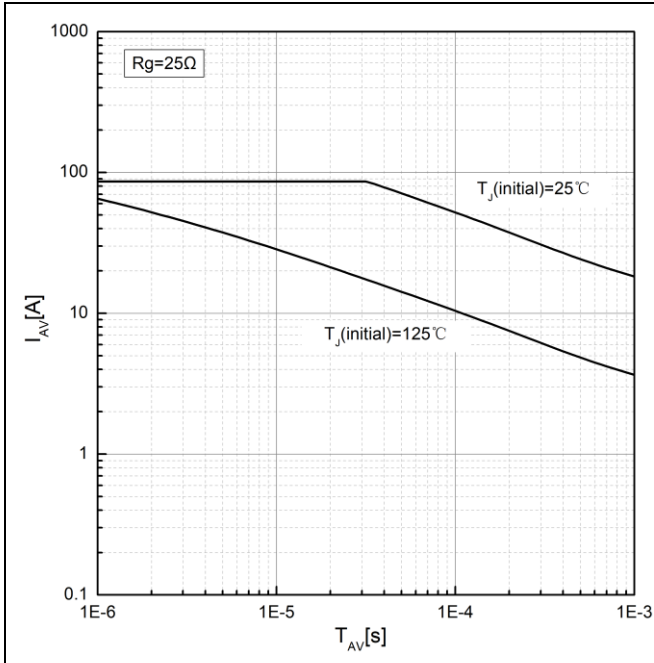
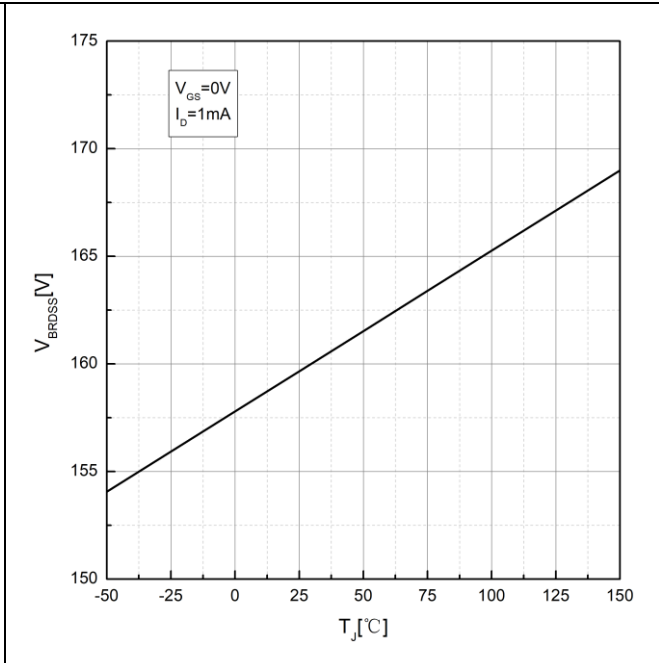
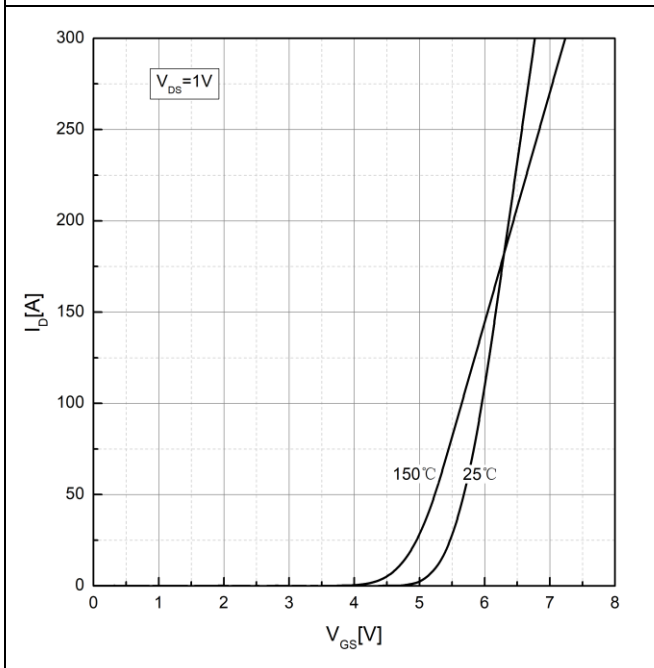
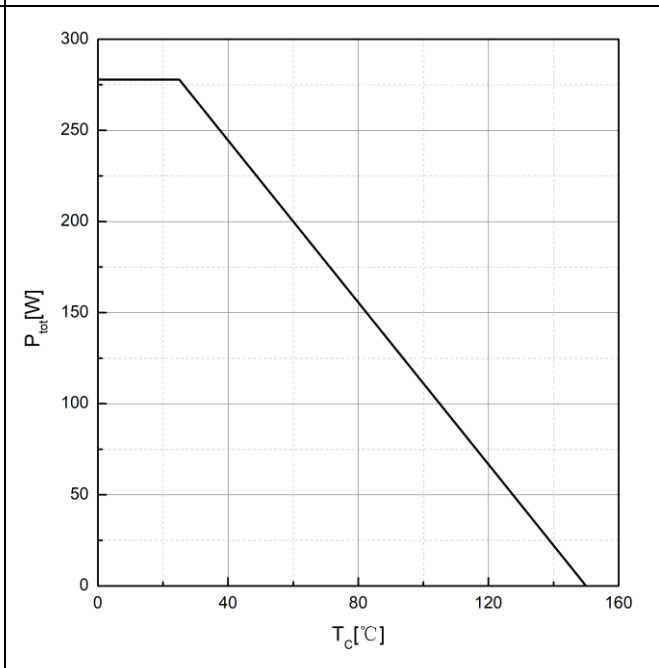
Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	150	-	-	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS} = 150V, V_{GS} = 0V, T_J = 25^{\circ}\text{C}$	-	-	1	μA
		$V_{DS} = 150V, V_{GS} = 0V, T_J = 125^{\circ}\text{C}$	-	-	100	μA
I_{GSS}	Gate-Source Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-100	-	100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	3.0	-	4.6	V
$R_{DS(on)}$	Static Drain-Source On-Resistance ^{note2}	$V_{GS} = 10V, I_D = 50A$	-	2.8	3.4	m Ω
		$V_{GS} = 8V, I_D = 25A$	-	3.0	3.6	m Ω
g_{FS}	Forward Transconductance	$V_{DS} = 1V, I_D = 50A$	-	150	-	S
Dynamic Characteristics						
R_g	Gate Resistance	$f = 1.0\text{MHz}$	-	0.5	-	Ω
C_{iss}	Input Capacitance	$V_{DS} = 75V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$	-	9700	-	pF
C_{oss}	Output Capacitance		-	830	-	pF
C_{rss}	Reverse Transfer Capacitance		-	14	-	pF
Q_g	Total Gate Charge	$V_{DS} = 75V, I_D = 50A,$ $V_{GS} = 10V$	-	137	-	nC
Q_{gs}	Gate-Source Charge		-	50	-	nC
Q_{gd}	Gate-Drain("Miller") Charge		-	28	-	nC
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS} = 75V, I_D = 50A,$ $R_G = 1\Omega, V_{GS} = 10V$	-	26	-	ns
t_r	Turn-On Rise Time		-	28	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	44	-	ns
t_f	Turn-Off Fall Time		-	16	-	ns
Source-Drain Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Diode Forward Current ^{note1,5}		-	-	205	A
I_{SM}	Maximum Pulsed Diode Forward Current ^{note2,5}		-	-	820	A
t_{rr}	Reverse Recovery Time	$T_J = 25^{\circ}\text{C}, I_S = 50A,$ $V_{GS} = 0V, di/dt = 400A/\mu s$	-	56	-	ns
Q_{rr}	Reverse Recovery Charge		-	128	-	nC
V_{SD} ^{note2}	Diode Forward Voltage	$I_S = 20A$	$T_J = 25^{\circ}\text{C}$	-	0.80	V
		$V_{GS} = 0V$		$T_J = 125^{\circ}\text{C}$	-	0.68

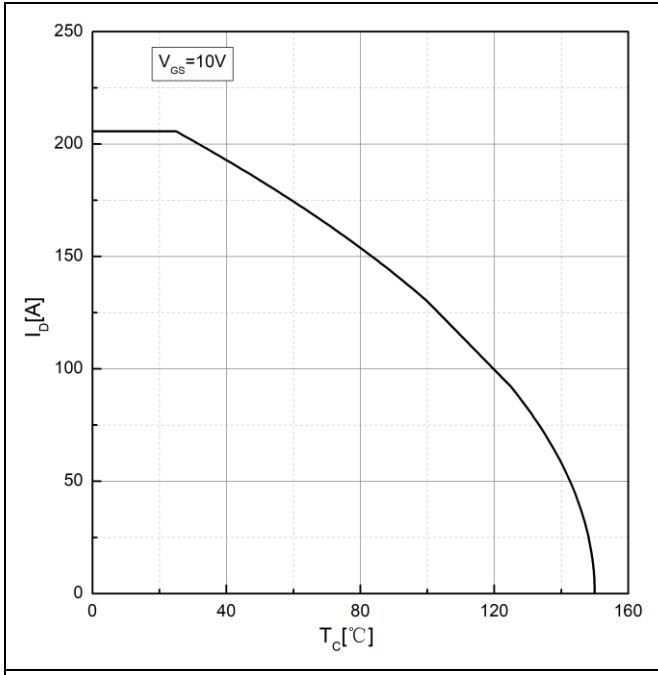
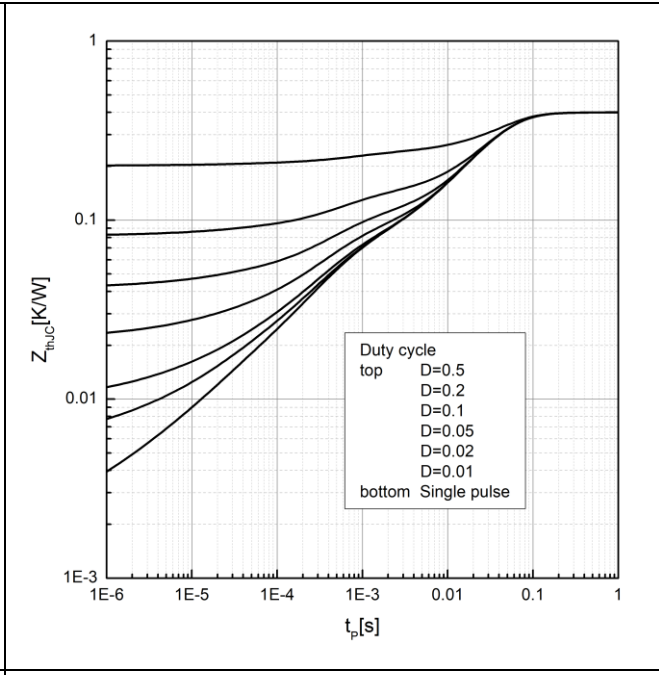
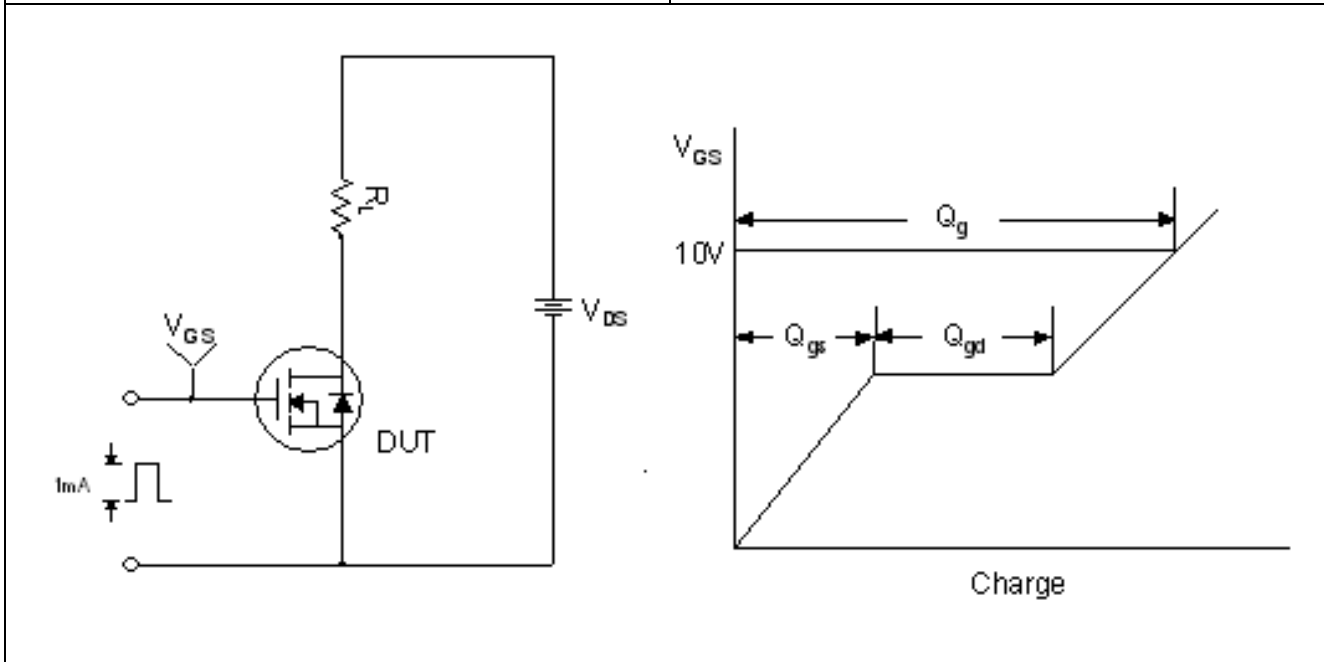
Note :

- 1.The data tested by surface mounted on one inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- 3.The EAS data shows Max. rating. The test condition is $L=0.5\text{mH}$, $I_{AS}= 86\text{ A}$.
- 4.The power dissipation is limited by 150°C junction temperature.
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

Typical Performance Characteristics

Figure 1. Output Characteristics, $T_J=25^\circ\text{C}$

Figure 2. Drain-source on resistance , $T_J=25^\circ\text{C}$

Figure 3. Forward characteristics of body diode

Figure 4. Gate Charge Characteristics


Figure 5. Capacitance Characteristics

Figure 6. Threshold Voltage Vs. Temperature

Figure 7. Drain-source on-state resistance

Figure 8. Maximum Safe Operating Area


Figure 9. Avalanche characteristics

Figure 10. Drain-source breakdown voltage

Figure 11. Transfer characteristics

Figure 12. Power dissipation


Figure 13. Drain current

Figure 14. Effective Transient Thermal Impedance

Figure 15. Gate Charge Test Circuit & Waveform

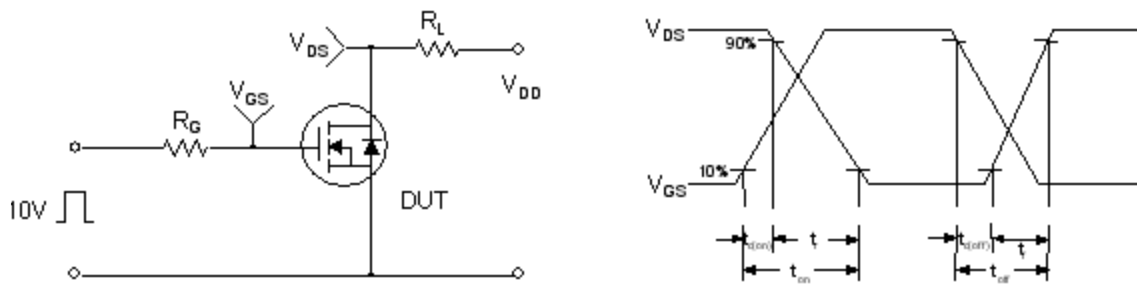


Figure 16. Resistive Switching Test Circuit & Waveforms

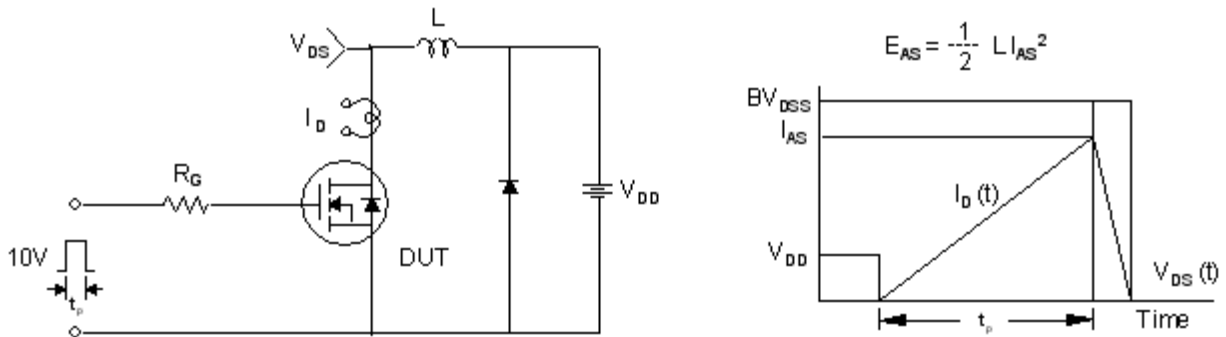


Figure 17. Unclamped Inductive Switching Test Circuit & Waveforms

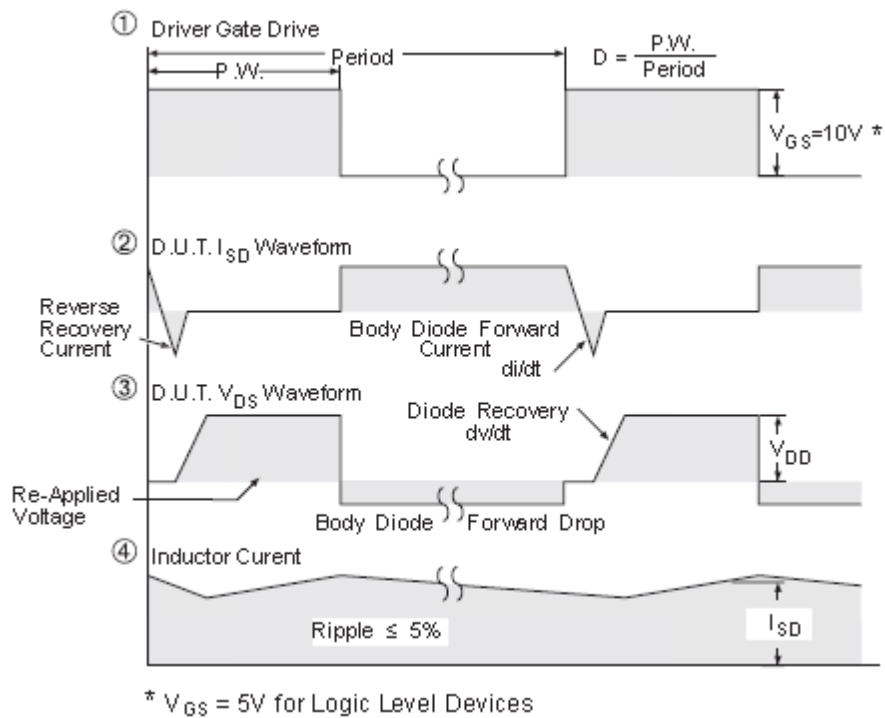
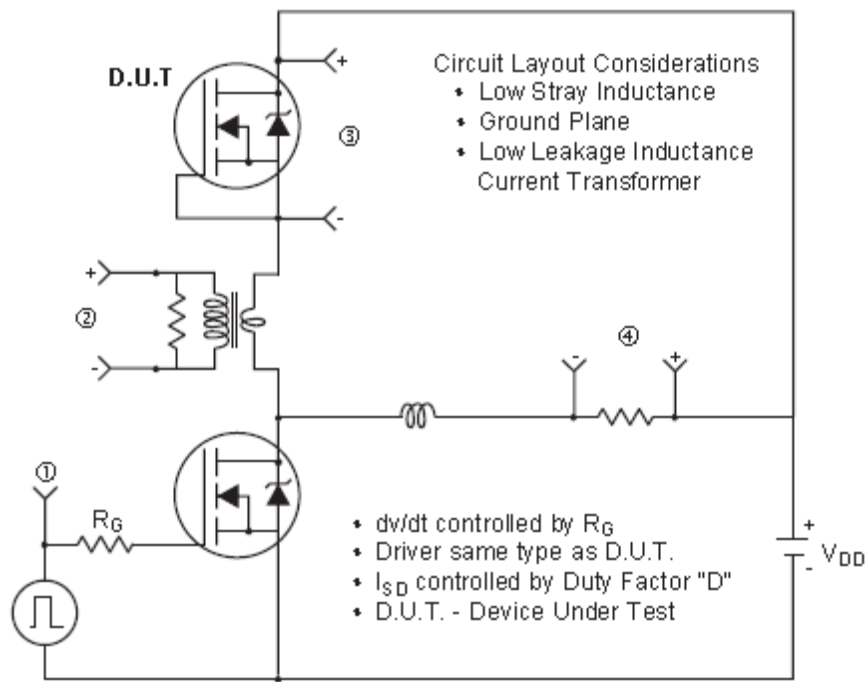
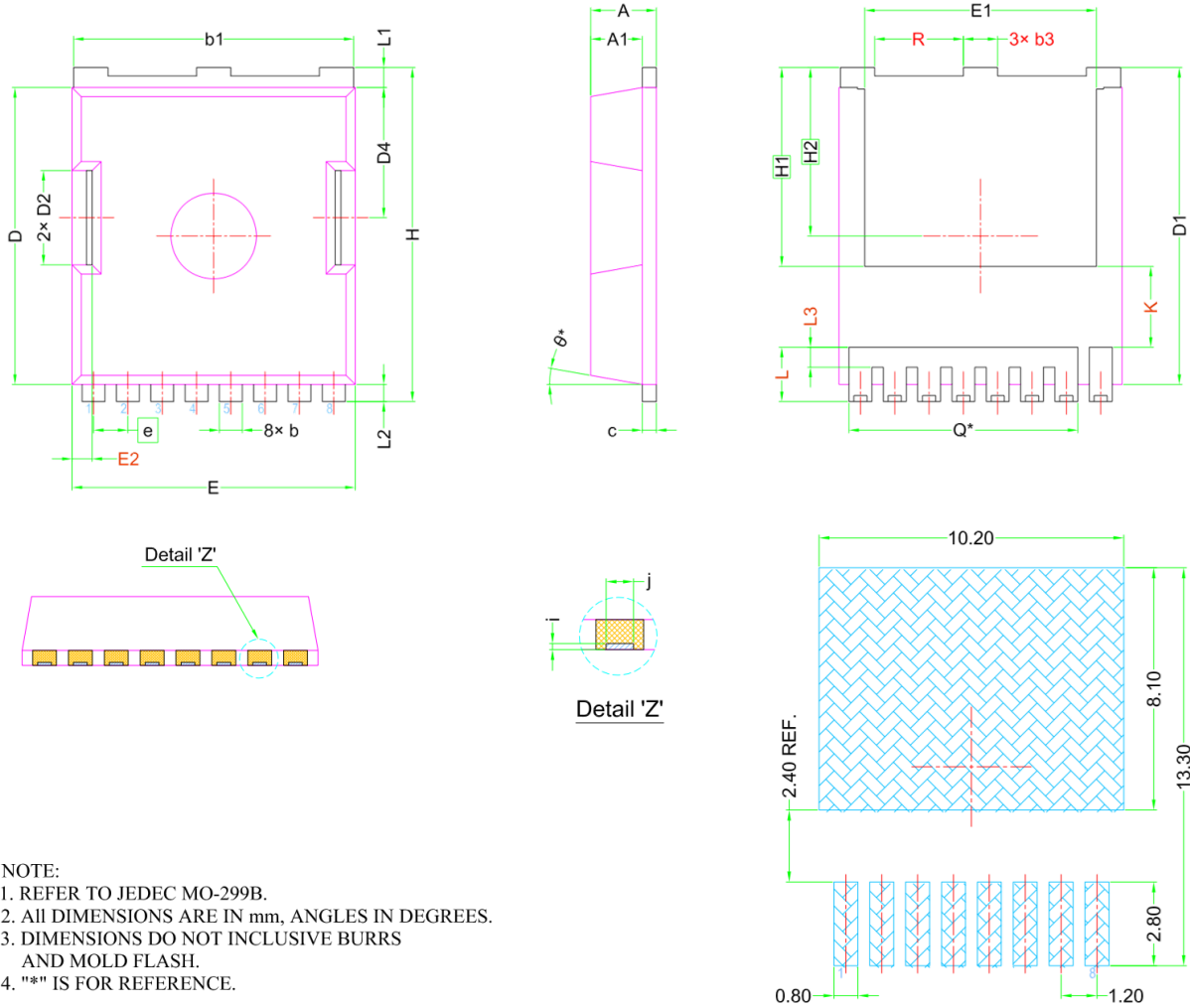


Figure 18. Peak Diode Recovery dv/dt Test Circuit & Waveforms (For N-channel)

Package outline


- NOTE:
1. REFER TO JEDEC MO-299B.
 2. All DIMENSIONS ARE IN mm, ANGLES IN DEGREES.
 3. DIMENSIONS DO NOT INCLUSIVE BURRS AND MOLD FLASH.
 4. "*" IS FOR REFERENCE.

SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b3	1.10	1.20	1.30
c	0.40	0.50	0.60
D	10.28	10.38	10.48
D1	10.98	11.08	11.18
D2	3.20	3.30	3.40
D4	4.45	4.55	4.65
E	9.80	9.90	1 0.00
E1	8.00	8.10	8.20
E2	0.60	0.70	0.80
e	1.20 BSC		

SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
H	11.58	11.68	11.78
H1	6.95 BSC		
H2	5.89 BSC		
i	0.10 REF.		
j	0.46 REF.		
K	2.80 REF.		
L	1.40	1.90	2.10
L1	0.60	0.70	0.80
L2	0.50	0.60	0.70
L3	0.30	0.70	0.80
N	8		
Q	8.00 REF.		
R	3.00	3.10	3.20
θ	10° REF.		

Figure 19. TOLL Package outline

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